

April 2013

# FDH50N50\_F133 / FDA50N50 N-Channel UniFET<sup>TM</sup> MOSFET 500 V, 50 A, 105 m $\Omega$

#### **Features**

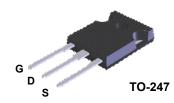
- $R_{DS(on)}$  = 105 m $\Omega$  (Max.) @  $V_{GS}$  = 10 V,  $I_D$  = 24 A
- Low Gate Charge (Typ. 105 nC)
- Low C<sub>rss</sub> (Typ.45 pF)
- · 100% Avalanche Tested
- · Improved dv/dt Capability

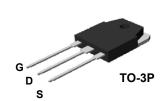
## **Applications**

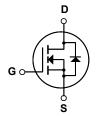
- · Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply

# **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor<sup>®</sup>, s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.







# **Absolute Maximum Ratings**

Symbol	Parameter		FDH50N50_F133/FDA50N50	Unit	
V <sub>DSS</sub>	Drain-Source Voltage			500	V
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		48 30.8	A A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	192	Α
V <sub>GSS</sub>	Gate-Source voltage			±20	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	1868	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	48	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	62.5	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
$P_D$	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate above 25°C		625 5	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

## **Thermal Characteristics**

Symbol	Parameter	FDH50N50_F133/FDA50N50	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.2	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max. 40		C/VV	

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDH50N50	FDH50N50_F133	TO-247	-	-	30
FDA50N50	FDA50N50	TO-3PN	-	-	30

# **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit	
Off Charac	Off Characteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	500			V	
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C		0.5		V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V V <sub>DS</sub> = 400V, T <sub>C</sub> = 125°C			25 250	μA μA	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 20V, V <sub>DS</sub> = 0V			100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -20V, V <sub>DS</sub> = 0V			-100	nA	
On Charac	teristics		I.				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V	
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 24A		0.089	0.105	Ω	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40V, I <sub>D</sub> = 48A		20		S	
Dynamic C	Dynamic Characteristics						
C <sub>iss</sub>	Input Capacitance	t Capacitance $V_{DS} = 25V, V_{GS} = 0V,$		4979	6460	pF	
C <sub>oss</sub>	Output Capacitance	f = 1.0MHz		760	1000	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	1		50	65	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 400V, V <sub>GS</sub> = 0V, f = 1.0MHz		161		pF	
Coss eff.	Effective Output Capacitance	V <sub>DS</sub> = 0V to 400V, V <sub>GS</sub> = 0V		342		pF	
Switching	Switching Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time $V_{DD} = 250V, I_D = 48A$			105	220	ns	
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25\Omega$		360	730	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time			225	460	ns	
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		230	470	ns	
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 400V, I <sub>D</sub> = 48A		105	137	nC	
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10V		33		nC	
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4)		45		nC	
Drain-Sour	rce Diode Characteristics and Maximur	n Ratings	l .		l	I	
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				48	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				192	Α	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 48A			1.4	V	
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>S</sub> = 48A		580		ns	
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt =100A/μs		10		μС	

#### NOTES

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1.46mH, I $_{AS}$  = 48A, V $_{DD}$  = 50V, R $_{G}$  = 25 $\Omega$ , Starting T $_{J}$  = 25°C
- 3.  $I_{SD} \le$  48A, di/dt  $\le$  200A/ $\mu$ s,  $V_{DD} \le$  BV $_{DSS}$ , Starting T $_J$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

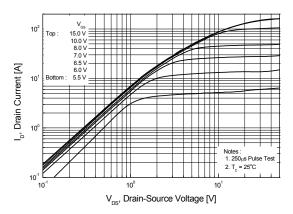


Figure 2. Transfer Characteristics

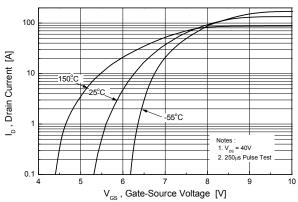


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

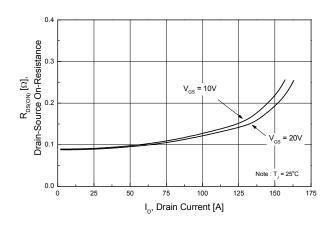


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

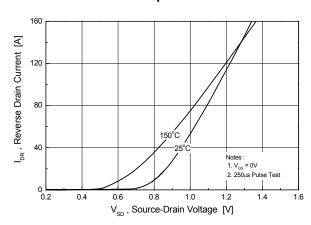


Figure 5. Capacitance Characteristics

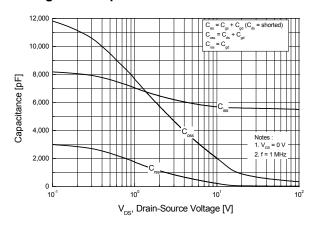
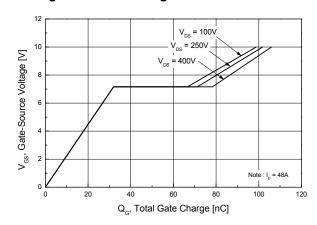


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

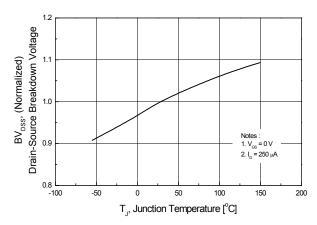


Figure 8. On-Resistance Variation vs. Temperature

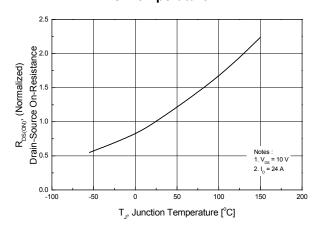


Figure 9. Maximum Safe Operating Area

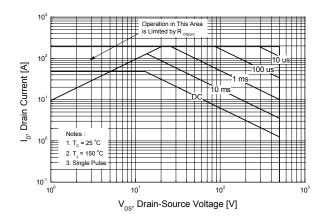


Figure 10. Maximum Drain Current vs. Case Temperature

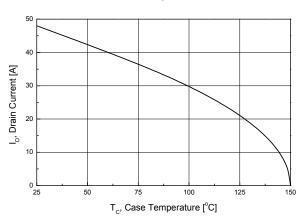


Figure 11. Typical Drain Current Slope vs. Gate Resistance

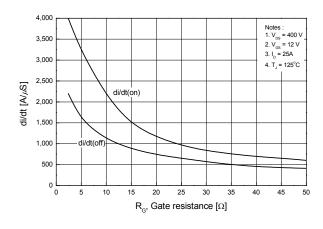
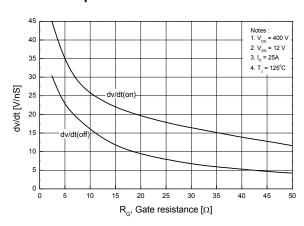


Figure 12. Typical Drain-Source Voltage Slope vs. Gate Resistance



# **Typical Performance Characteristics** (Continued)

Figure 13. Typical Switching Losses vs. Gate Resistance

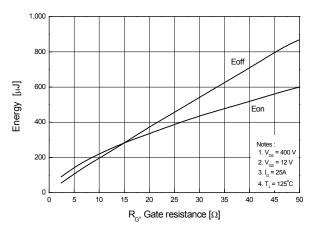


Figure 14. Unclamped Inductive Switching Capability

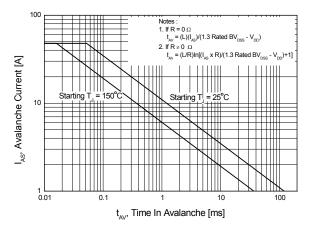
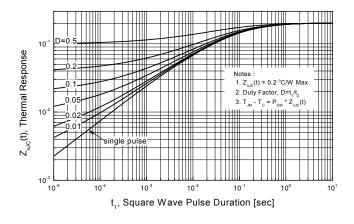
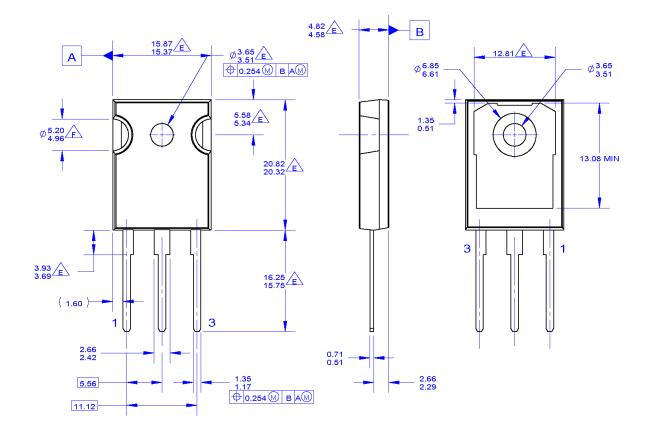


Figure 15. Transient Thermal Resistance Curve



### **Mechanical Dimensions**

# TO-247A03



NOTES: UNLESS OTHERWISE SPECIFIED.

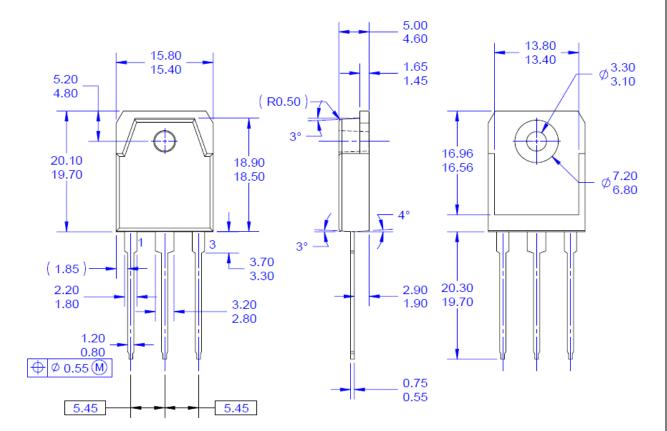
- PACKAGE REFERENCE: JEDEC TO-247, ISSUE E, VARIATION AB, DATED JUNE, 2004.
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- D. DRAWING CONFORMS TO ASME Y14.5 1994
- DOES NOT COMPLY JEDEC STANDARD VALUE

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G. DRAWING FILENAME: MKT-TO247A03\_REV03

Dimensions in Millimeters

### **Mechanical Dimensions**

# TO-3PN





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